

### General Description

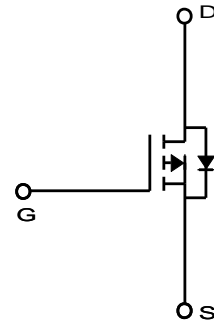
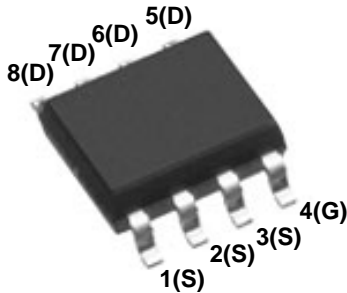
The MDS3652 uses advanced MagnaChip's MOSFET Technology to provide low on-state resistance, high switching performance and excellent reliability

### Features

- $V_{DS} = -30V$
- $I_D = -11A$  @  $V_{GS} = -10V$
- $R_{DS(ON)} < 17m\Omega$  @  $V_{GS} = -10V$   
 $< 27m\Omega$  @  $V_{GS} = -4.5V$

### Applications

- Load Switch
- General purpose applications



### Absolute Maximum Ratings ( $T_a = 25^\circ C$ unless otherwise noted)

Characteristics	Symbol	Rating	Unit	
Drain-Source Voltage	$V_{DSS}$	-30	V	
Gate-Source Voltage	$V_{GSS}$	$\pm 20$	V	
Continuous Drain Current	$I_D$	$T_a = 25^\circ C$	-11	A
		$T_a = 100^\circ C$	-7	A
Pulsed Drain Current	$I_{DM}$	-60	A	
Power Dissipation <sup>(1)</sup>	$P_D$	$T_a = 25^\circ C$	3.1	W
		$T_a = 100^\circ C$	1.2	
Single Pulse Avalanche Energy <sup>(2)</sup>	$E_{AS}$	60	mJ	
Junction and Storage Temperature Range	$T_J, T_{stg}$	-55~150	$^\circ C$	

### Thermal Characteristics

Characteristics	Symbol	Rating	Unit
Thermal Resistance, Junction-to-Ambient(Steady-State) <sup>(1)</sup>	$R_{\theta JA}$	40	$^\circ C/W$
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	25	

## Ordering Information

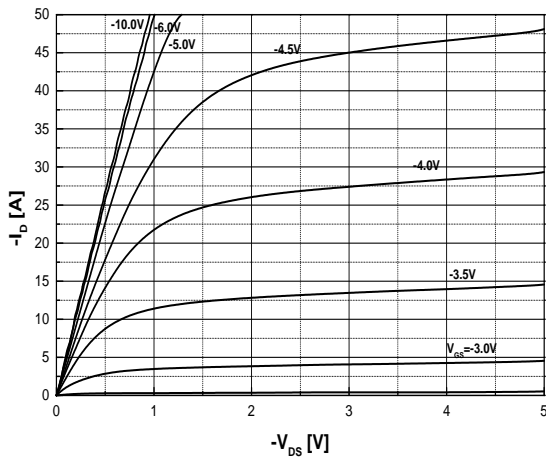
Part Number	Temp. Range	Package	Packing	RoHS Status
MDS3652URH	-55~150°C	SOIC-8	Tape & Reel	Halogen Free

## Electrical Characteristics (T<sub>a</sub> = 25°C unless otherwise noted)

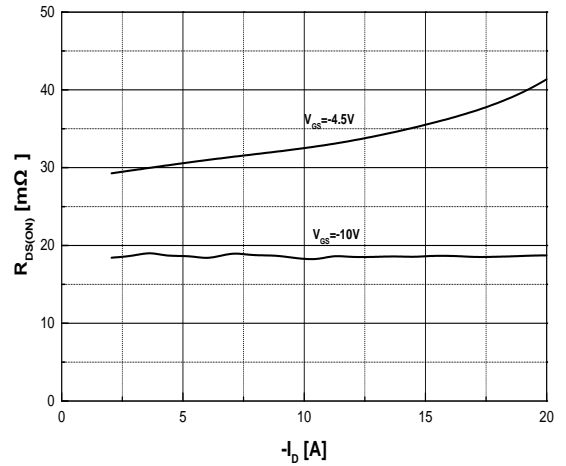
Characteristics	Symbol	Test Condition	Min	Typ	Max	Unit
<b>Static Characteristics</b>						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	I <sub>D</sub> = -250μA, V <sub>GS</sub> = 0V	-30	-	-	V
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250μA	-1.0	-1.9	-3.0	
Drain Cut-Off Current	I <sub>DSS</sub>	V <sub>DS</sub> = -24V, V <sub>GS</sub> = 0V	-	-	-1	μA
Gate Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0V	-	-	±0.1	
Drain-Source ON Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> = -10V, I <sub>D</sub> = -11A	-	13	17	mΩ
		V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -6A	-	21	27	
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> = -5V, I <sub>D</sub> = -11A	-	25	-	S
<b>Dynamic Characteristics</b>						
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> = -15V, I <sub>D</sub> = -11A, V <sub>GS</sub> = -10V	-	35	-	nC
Gate-Source Charge	Q <sub>gs</sub>		-	7.8	-	
Gate-Drain Charge	Q <sub>gd</sub>		-	6.2	-	
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> = -15V, V <sub>GS</sub> = 0V, f = 1.0MHz	-	1770	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>		-	150	-	
Output Capacitance	C <sub>oss</sub>		-	350	-	
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>GS</sub> = -10V, V <sub>DS</sub> = -15V, R <sub>L</sub> = 2.7Ω, R <sub>GEN</sub> = 3Ω	-	13.0	-	ns
Turn-On Rise Time	t <sub>r</sub>		-	26.8	-	
Turn-Off Delay Time	t <sub>d(off)</sub>		-	34.4	-	
Turn-Off Fall Time	t <sub>f</sub>		-	17.4	-	
<b>Drain-Source Body Diode Characteristics</b>						
Source-Drain Diode Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> = 1A, V <sub>GS</sub> = 0V	-	-0.75	-	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = -11A, di/dt = 100A/μs	-	27	-	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>		-	12	-	nC

Note :

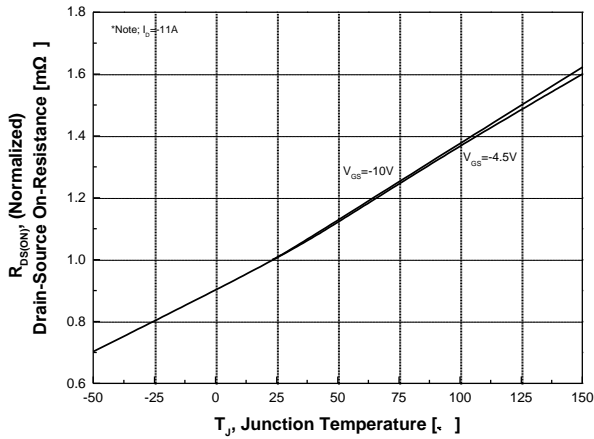
- Surface mounted FR-4 board by JEDEC (jesd51-7)
- Starting T<sub>J</sub> = 25°C, L = 1mH, I<sub>AS</sub> = 11A, V<sub>DD</sub> = 15V, V<sub>GS</sub> = 10V



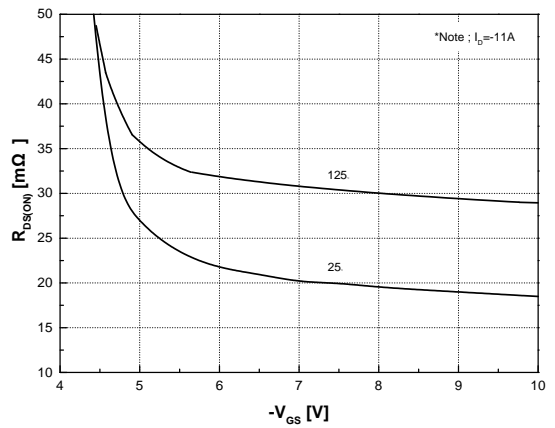
**Fig.1 On-Region Characteristics**



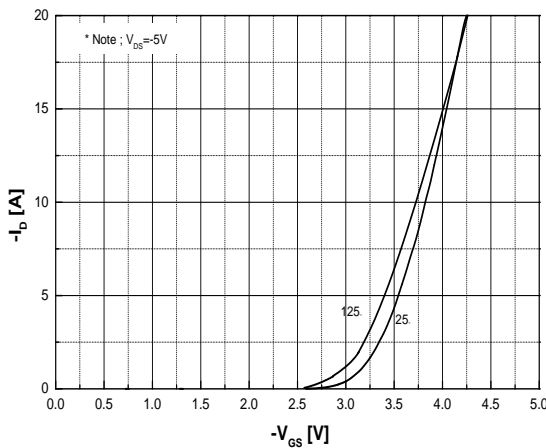
**Fig.2 On-Resistance Variation with Drain Current and Gate Voltage**



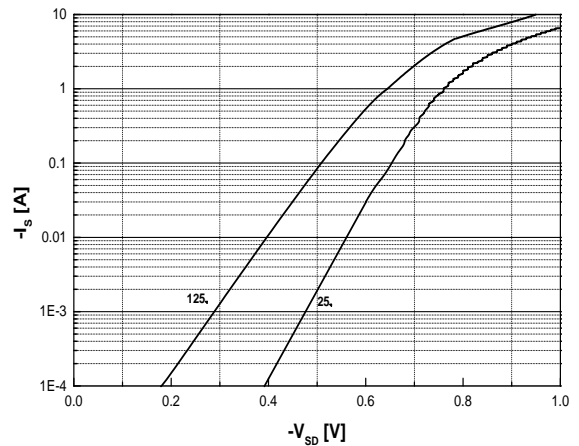
**Fig.3 On-Resistance Variation with Temperature**



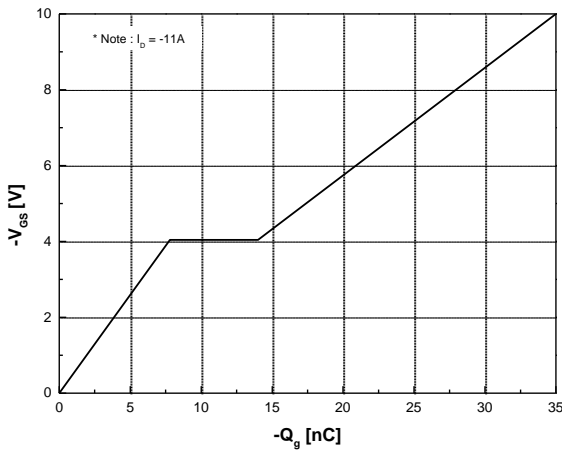
**Fig.4 On-Resistance Variation with Gate to Source Voltage**



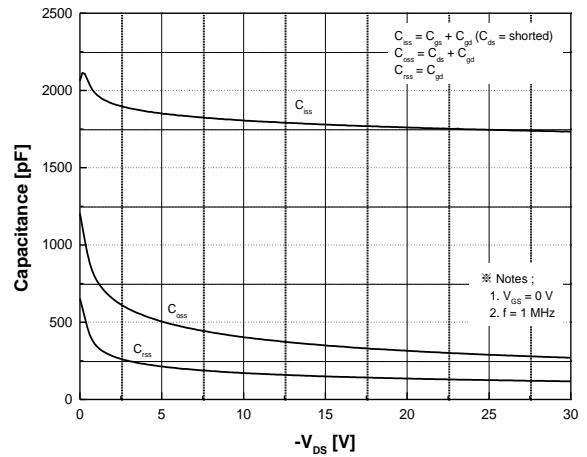
**Fig.5 Transfer Characteristics**



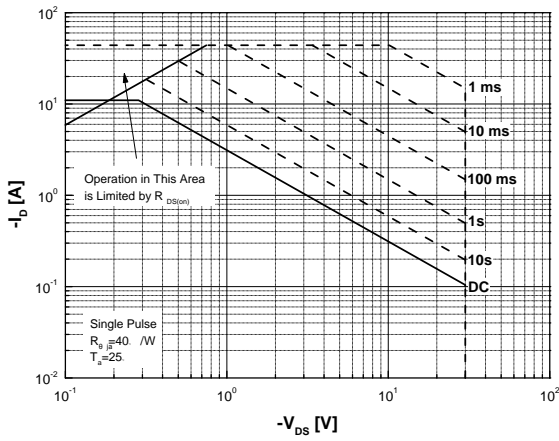
**Fig.6 Body Diode Forward Voltage Variation with Source Current and Temperature**



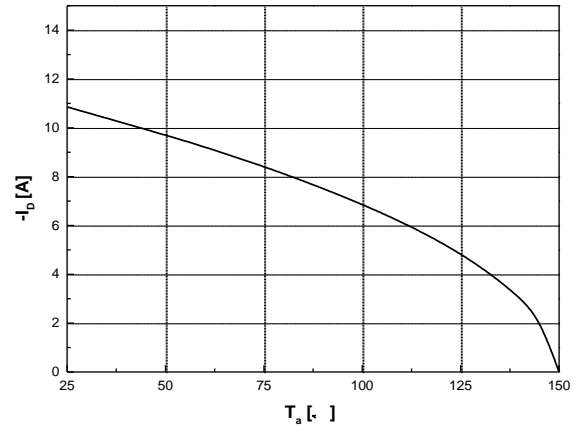
**Fig.7 Gate Charge Characteristics**



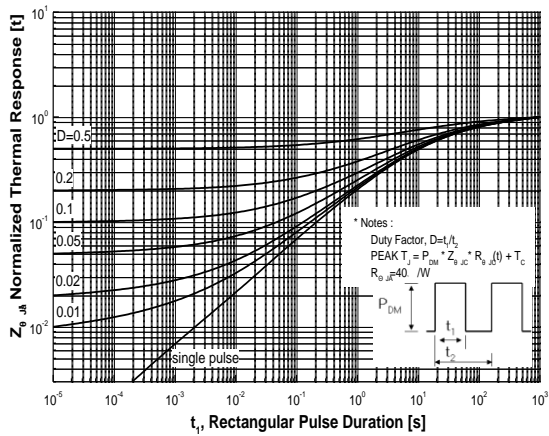
**Fig.8 Capacitance Characteristics**



**Fig.9 Maximum Safe Operating Area**



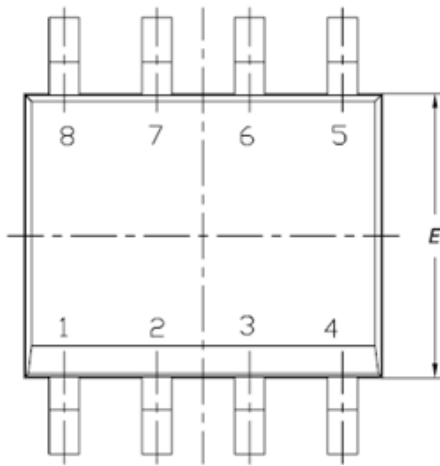
**Fig.10 Maximum Drain Current vs. Ambient Temperature**



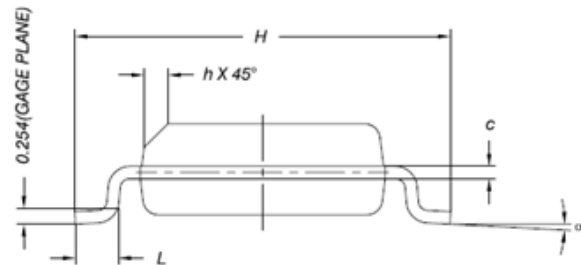
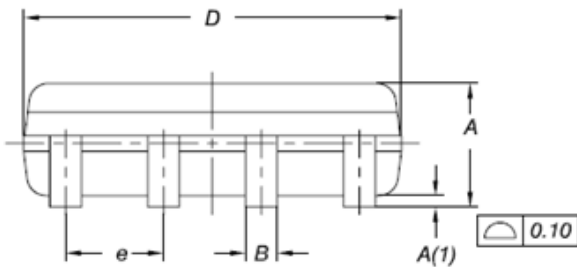
**Fig.11 Transient Thermal Response Curve**

### 8 Leads, SOIC

Dimensions are in millimeters unless otherwise specified



Symbol	Min	Nom	Max
A	-	-	1.75
A(1)	0.10	-	0.25
B	0.31	-	0.51
C	0.10	-	0.25
D	4.9 BSC		
E	3.9 BSC		
e	1.27 BSC		
H	6.0 BSC		
L	0.40	-	1.27
a	0	-	8
h	0.250	-	0.500
L2(Gage plane)	0.25 BSC		



**DISCLAIMER:**

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